

Document Title

128K x 8 Ultra Low Power and Low V_{cc} SRAM

Revision History

<u>Revision No</u>	<u>History</u>	<u>Draft Date</u>	<u>Remark</u>
0A	Initial Draft	September 13,2001	

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128K x 8 LOW POWER and LOW V_{cc} CMOS STATIC RAM

FEATURES

- Access times of 45, 55, and 70 ns
- Low active power: 60 mW (typical)
- Low standby power: 15 μ W (typical) CMOS standby
- Low data retention voltage: 2V (min.)
- Available in Low Power (-L) and Ultra Low Power (-LL)
- Output Enable (\overline{OE}) and two Chip Enable ($\overline{CE1}$ and $\overline{CE2}$) inputs for ease in applications
- TTL compatible inputs and outputs
- Single 2.7V to 3.3V power supply

DESCRIPTION

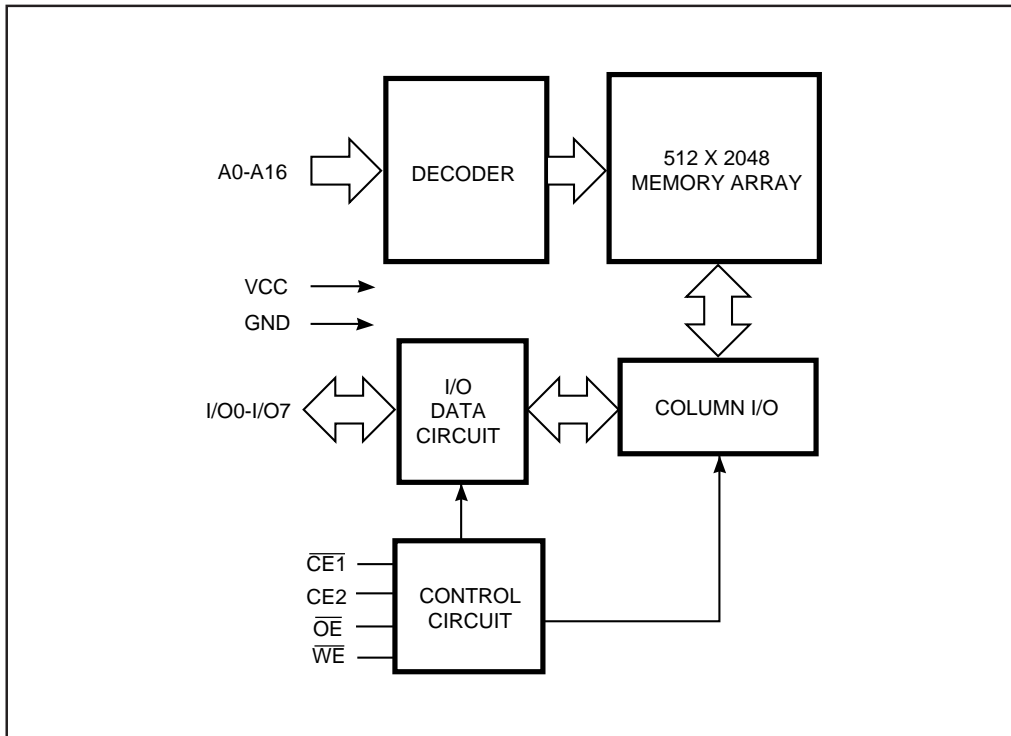
The *ICSI* IC62LV1024AL and IC62LV1024ALL are low power and low V_{cc}, 131,072-word by 8-bit CMOS static RAMs. They are fabricated using *ICSI*'s high-performance CMOS technology. This highly reliable process coupled with innovative circuit design techniques, yields higher performance and low power consumption devices.

When $\overline{CE1}$ is HIGH or $\overline{CE2}$ is LOW (deselected), the device assumes a standby mode at which the power dissipation can be reduced by using CMOS input levels.

Easy memory expansion is provided by using two Chip Enable inputs, $\overline{CE1}$ and $\overline{CE2}$. The active LOW Write Enable (\overline{WE}) controls both writing and reading of the memory.

The IC62LV1024AL and IC62LV1024ALL are available in 32-pin 8*20mm TSOP-1, 8*13.4mm TSOP-1, 450mil SOP and 48-pin 6*8mm TF-BGA.

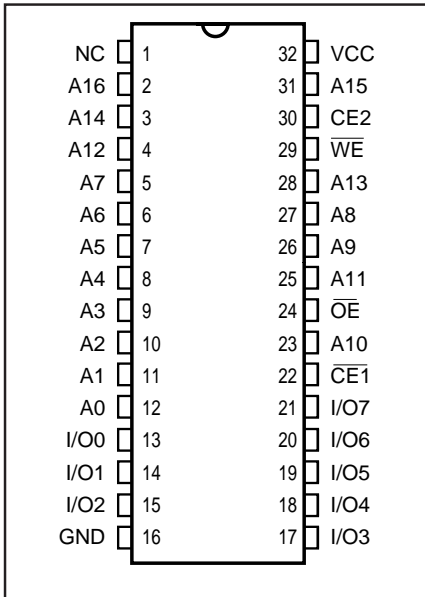
FUNCTIONAL BLOCK DIAGRAM



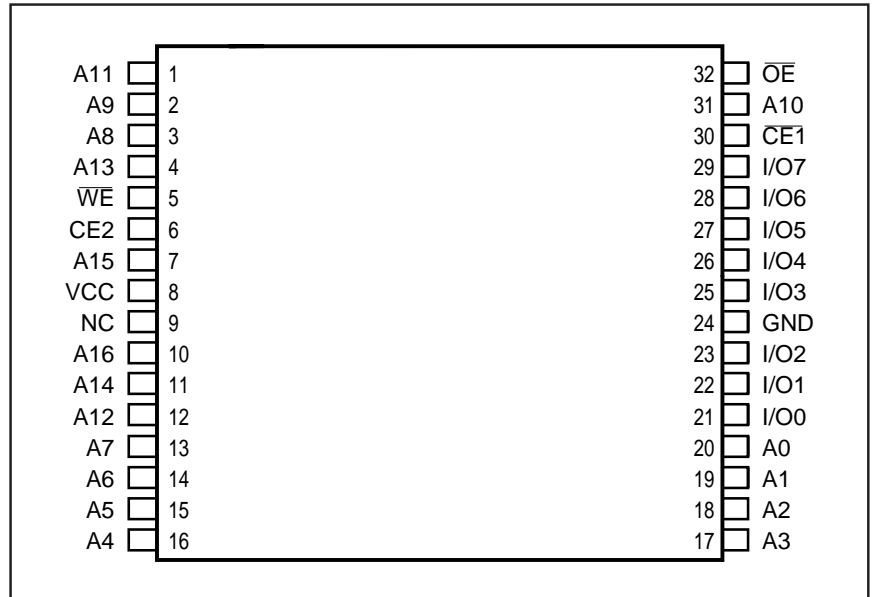
IC62LV1024AL IC62LV1024ALL



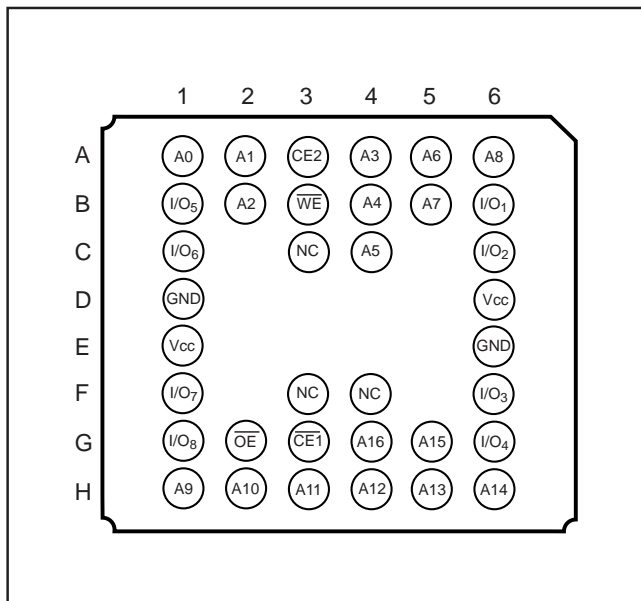
PIN CONFIGURATION 32-Pin SOP



PIN CONFIGURATION 32-Pin 8x20mm TSOP-1 and 8x13.4mm TSOP-1



48-Pin 6x8mm TF-BGA



PIN DESCRIPTIONS

A0-A16	Address Inputs
CE1	Chip Enable 1 Input
CE2	Chip Enable 2 Input
OE	Output Enable Input
WE	Write Enable Input
I/O0-I/O7	Input/Output
NC	No Connection
Vcc	Power
GND	Ground

OPERATING RANGE

Range	Ambient Temperature	Vcc
Commercial	0°C to +70°C	2.7V to 3.3V
Industrial	-40°C to +85°C	2.7V to 3.3V

TRUTH TABLE

Mode	\overline{WE}	$\overline{CE1}$	CE2	\overline{OE}	I/O Operation	Vcc Current
Not Selected (Power-down)	X	H	X	X	High-Z	I _{SB1} , I _{SB2}
	X	X	L	X	High-Z	I _{SB1} , I _{SB2}
Output Disabled	H	L	H	H	High-Z	I _{CC}
Read	H	L	H	L	D _{OUT}	I _{CC}
Write	L	L	H	X	D _{IN}	I _{CC}

ABSOLUTE MAXIMUM RATINGS⁽¹⁾

Symbol	Parameter	Value	Unit
V _{TERM}	Terminal Voltage with Respect to GND	-0.5 to +3.6	V
V _{CC}	Vcc related to GND	-0.3 to +3.6	V
T _{BIAS}	Temperature Under Bias	-40 to +85	°C
T _{STG}	Storage Temperature	-65 to +150	°C
P _T	Power Dissipation	0.7	W

Notes:

1. Stress greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

CAPACITANCE^(1,2)

Symbol	Parameter	Conditions	Max.	Unit
C _{IN}	Input Capacitance	V _{IN} = 0V	6	pF
C _{OUT}	Output Capacitance	V _{OUT} = 0V	8	pF

Notes:

1. Tested initially and after any design or process changes that may affect these parameters.
2. Test conditions: T_A = 25°C, f = 1 MHz, V_{CC} = 3.0V.

DC ELECTRICAL CHARACTERISTICS (Over Operating Range)

Symbol	Parameter	Test Conditions	Min.	Max.	Unit
V _{OH}	Output HIGH Voltage	V _{CC} = Min., I _{OH} = -1.0 mA	2.2	—	V
V _{OL}	Output LOW Voltage	V _{CC} = Min., I _{OL} = 2.1 mA	—	0.4	V
V _{IH}	Input HIGH Voltage		2.2	V _{CC} + 0.3	V
V _{IL}	Input LOW Voltage ⁽¹⁾		-0.3	0.4	V
I _{LI}	Input Leakage	GND ≤ V _{IN} ≤ V _{CC}	-1	1	μA
I _{LO}	Output Leakage	GND ≤ V _{OUT} ≤ V _{CC}	-1	1	μA

Notes:

1. V_{IL} = -3.0V for pulse width less than 10 ns.

IC62LV1024AL POWER SUPPLY CHARACTERISTICS⁽¹⁾ (Over Operating Range)

Symbol	Parameter	Test Conditions		-45L ns		-55L ns		-70L ns		Unit
				Min.	Max.	Min.	Max.	Min.	Max.	
I _{CC}	V _{CC} Dynamic Operating Supply Current	V _{CC} = Max., $\overline{CE} = V_{IL}$ I _{OUT} = 0 mA, f = f _{MAX}	Com.	—	40	—	35	—	30	mA
			Ind.	—	45	—	40	—	35	
I _{SB1}	TTL Standby Current (TTL Inputs)	V _{CC} = Max., V _{IN} = V _{IH} or V _{IL} , $\overline{CE1} \geq V_{IH}$ or CE2 ≤ V _{IL} , f = 0	Com.	—	0.8	—	0.8	—	0.8	mA
			Ind.	—	1	—	1	—	1	
I _{SB2}	CMOS Standby Current (CMOS Inputs)	V _{CC} = Max., f = 0 $\overline{CE1} \geq V_{CC} - 0.2V$, CE2 ≤ 0.2V, or V _{IN} ≥ V _{CC} - 0.2V, V _{IN} ≤ 0.2V	Com.	—	50	—	50	—	50	μA
			Ind.	—	75	—	75	—	75	

Note:

1. At f = f_{MAX}, address and data inputs are cycling at the maximum frequency, f = 0 means no input lines change.

IC62LV1024ALL POWER SUPPLY CHARACTERISTICS⁽¹⁾ (Over Operating Range)

Symbol	Parameter	Test Conditions		-45LL ns		-55LL ns		-70LL ns		Unit
				Min.	Max.	Min.	Max.	Min.	Max.	
I _{CC}	V _{CC} Dynamic Operating Supply Current	V _{CC} = Max., $\overline{CE} = V_{IL}$ I _{OUT} = 0 mA, f = f _{MAX}	Com.	—	40	—	35	—	30	mA
			Ind.	—	45	—	40	—	35	
I _{SB1}	TTL Standby Current (TTL Inputs)	V _{CC} = Max., V _{IN} = V _{IH} or V _{IL} , $\overline{CE1} \geq V_{IH}$ or CE2 ≤ V _{IL} , f = 0	Com.	—	0.8	—	0.8	—	0.8	mA
			Ind.	—	1	—	1	—	1	
I _{SB2}	CMOS Standby Current (CMOS Inputs)	V _{CC} = Max., f = 0 $\overline{CE1} \geq V_{CC} - 0.2V$, CE2 ≤ 0.2V, or V _{IN} ≥ V _{CC} - 0.2V, V _{IN} ≤ 0.2V	Com.	—	5	—	5	—	5	μA
			Ind.	—	10	—	10	—	10	

Note:

1. At f = f_{MAX}, address and data inputs are cycling at the maximum frequency, f = 0 means no input lines change.

READ CYCLE SWITCHING CHARACTERISTICS⁽¹⁾ (Over Operating Range)

Symbol	Parameter	-45		-55		-70		Unit
		Min.	Max.	Min.	Max.	Min.	Max.	
t _{RC}	Read Cycle Time	45	—	55	—	70	—	ns
t _{AA}	Address Access Time	—	45	—	55	—	70	ns
t _{OHA}	Output Hold Time	10	—	10	—	10	—	ns
t _{ACE1}	$\overline{CE1}$ Access Time	—	45	—	55	—	70	ns
t _{ACE2}	CE2 Access Time	—	45	—	55	—	70	ns
t _{DOE}	\overline{OE} Access Time	—	20	—	25	—	35	ns
t _{LZOE⁽²⁾}	\overline{OE} to Low-Z Output	0	—	5	—	5	—	ns
t _{HZOE⁽²⁾}	\overline{OE} to High-Z Output	0	15	0	20	0	25	ns
t _{LZCE1⁽²⁾}	$\overline{CE1}$ to Low-Z Output	5	—	7	—	10	—	ns
t _{LZCE2⁽²⁾}	CE2 to Low-Z Output	5	—	7	—	10	—	ns
t _{HZCE⁽²⁾}	$\overline{CE1}$ or CE2 to High-Z Output	0	15	0	20	0	25	ns

Notes:

1. Test conditions assume signal transition times of 5 ns or less, timing reference levels of 1.5V, input pulse levels of 0.4V to 2.2V and output loading specified in Figure 1.
2. Tested with the load in Figure 2. Transition is measured ± 500 mV from steady-state voltage. Not 100% tested.

AC TEST CONDITIONS

Parameter	Unit
Input Pulse Level	0.4V to 2.2V
Input Rise and Fall Times	5 ns
Input and Output Timing and Reference Level	1.5V
Output Load	See Figures 1

AC TEST LOADS

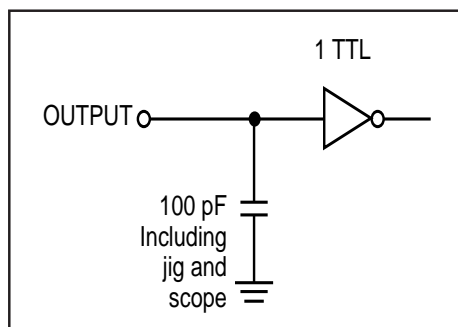


Figure 1.

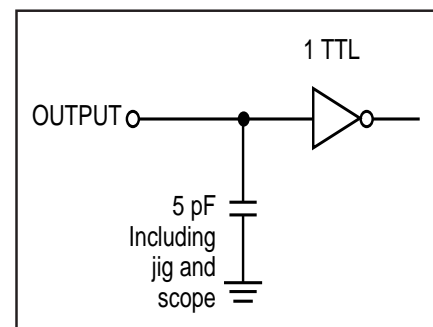
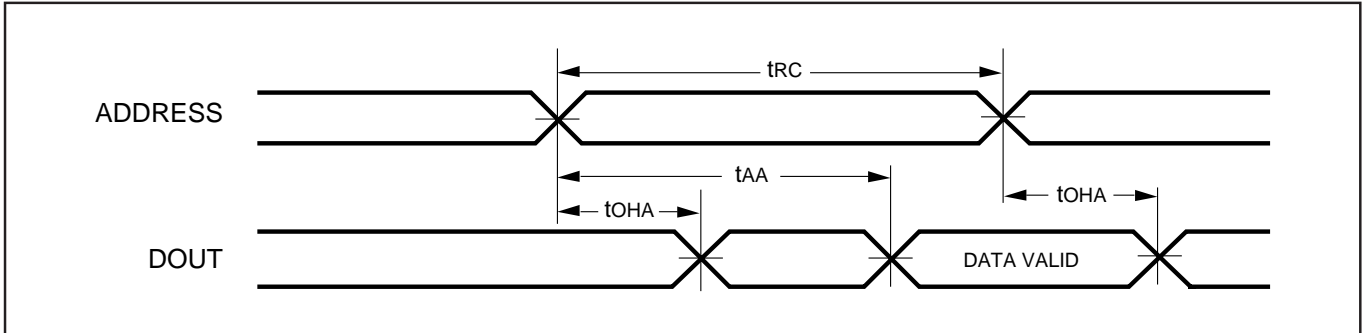


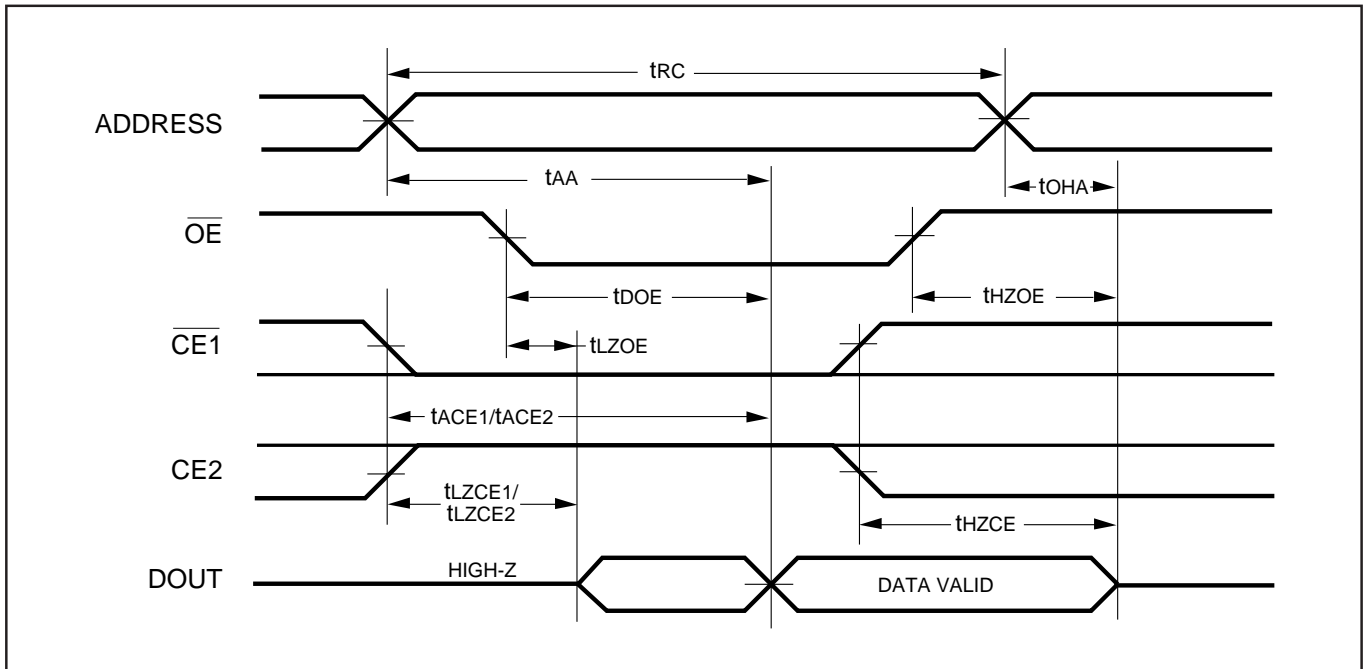
Figure 2.

AC WAVEFORMS

READ CYCLE NO. 1^(1,2)



READ CYCLE NO. 2^(1,3)



Notes:

1. WE is HIGH for a Read Cycle.
2. The device is continuously selected. \overline{OE} , $\overline{CE1} = V_{IL}$, $CE2 = V_{IH}$.
3. Address is valid prior to or coincident with $\overline{CE1}$ LOW and $CE2$ HIGH transitions.

WRITE CYCLE SWITCHING CHARACTERISTICS^(1,3) (Over Operating Range, Standard and Low Power)

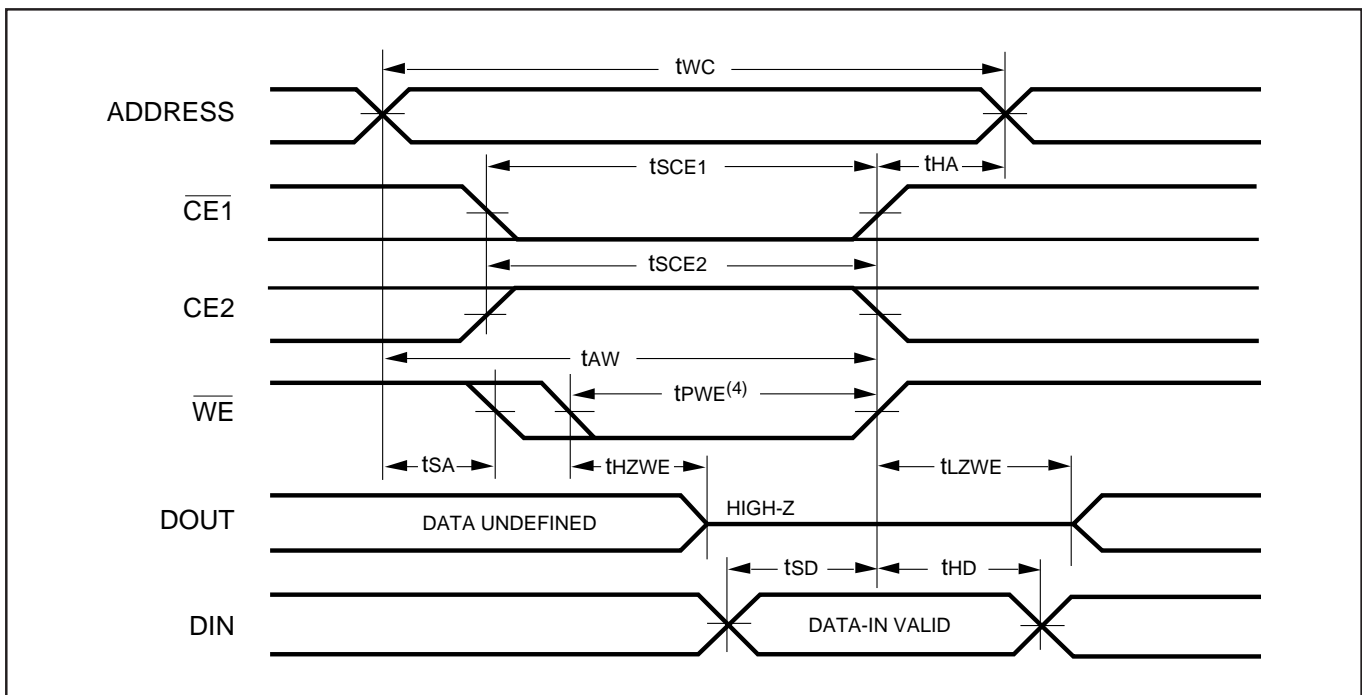
Symbol	Parameter	-45		-55		-70		Unit
		Min.	Max.	Min.	Max.	Min.	Max.	
t _{WC}	Write Cycle Time	45	—	55	—	70	—	ns
t _{SCE1}	$\overline{CE1}$ to Write End	35	—	50	—	60	—	ns
t _{SCE2}	CE2 to Write End	35	—	50	—	60	—	ns
t _{AW}	Address Setup Time to Write End	35	—	50	—	60	—	ns
t _{HA}	Address Hold from Write End	0	—	0	—	0	—	ns
t _{SA}	Address Setup Time	0	—	0	—	0	—	ns
t _{PWE⁽⁴⁾}	\overline{WE} Pulse Width	35	—	40	—	55	—	ns
t _{SD}	Data Setup to Write End	25	—	25	—	30	—	ns
t _{HD}	Data Hold from Write End	0	—	0	—	0	—	ns
t _{HZWE⁽²⁾}	\overline{WE} LOW to High-Z Output	—	15	—	20	0	25	ns
t _{LZWE⁽²⁾}	\overline{WE} HIGH to Low-Z Output	5	—	5	—	5	—	ns

Notes:

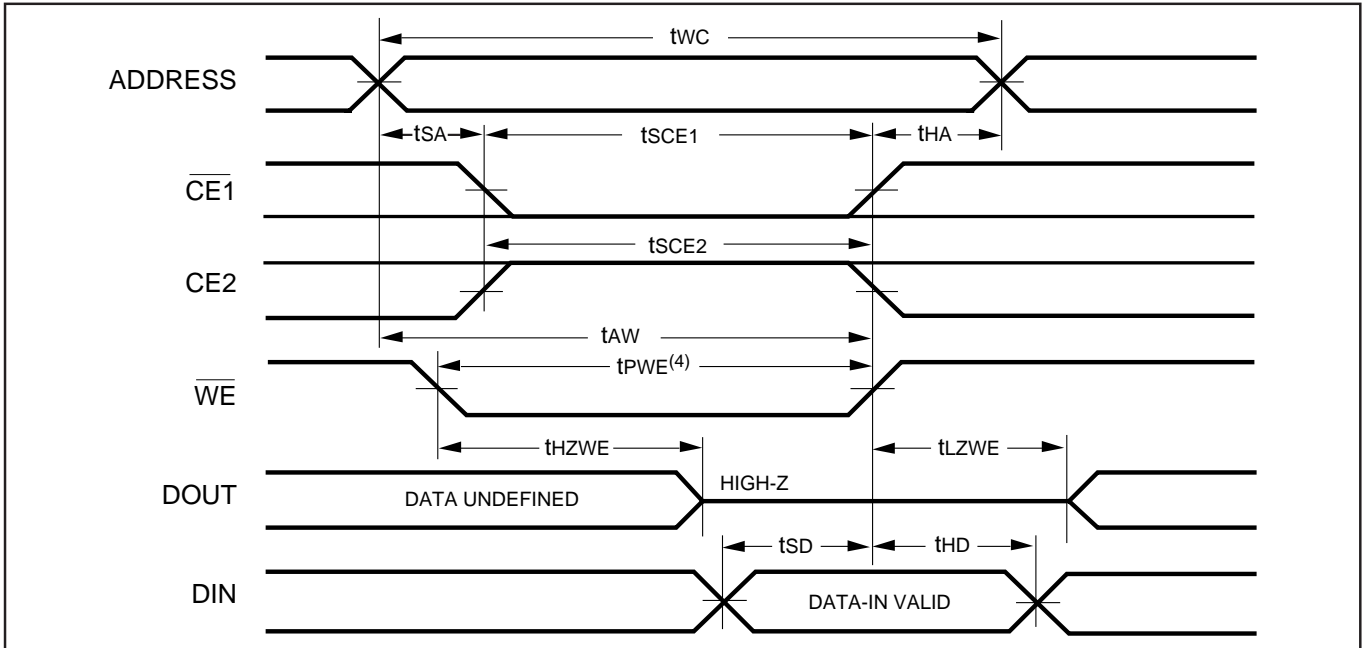
1. Test conditions assume signal transition times of 5 ns or less, timing reference levels of 1.5V, input pulse levels of 0.4V to 2.2V and output loading specified in Figure 1.
2. Tested with the load in Figure 2. Transition is measured ± 500 mV from steady-state voltage. Not 100% tested.
3. The internal write time is defined by the overlap of $\overline{CE1}$ LOW, CE2 HIGH and \overline{WE} LOW. All signals must be in valid states to initiate a Write, but any one can go inactive to terminate the Write. The Data Input Setup and Hold timing are referenced to the rising or falling edge of the signal that terminates the Write.
4. Tested with \overline{OE} HIGH.

AC WAVEFORMS

WRITE CYCLE NO. 1 (\overline{WE} Controlled)^(1,2)



WRITE CYCLE NO. 2 ($\overline{CE1}$, CE2 Controlled)^(1,2)



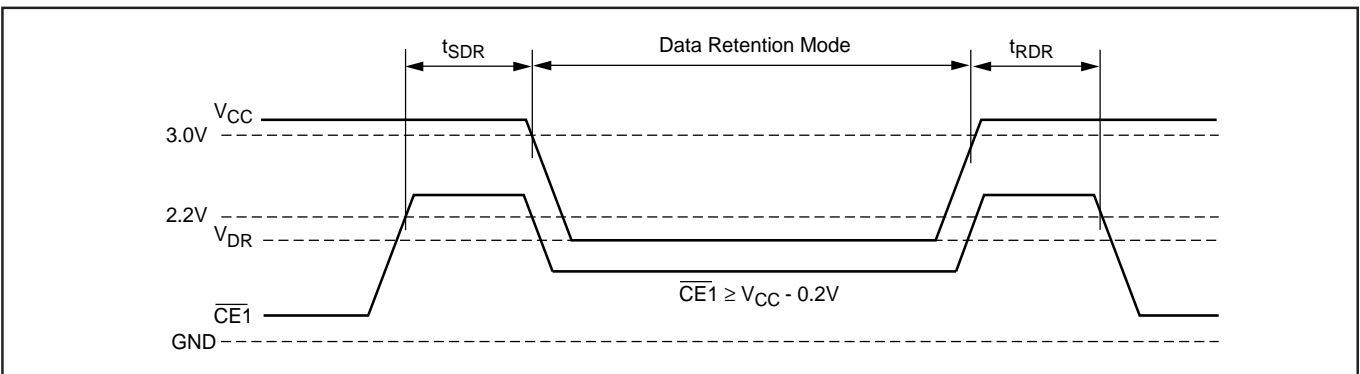
Notes:

1. The internal write time is defined by the overlap of $\overline{CE1}$ LOW, CE2 HIGH and \overline{WE} LOW. All signals must be in valid states to initiate a Write, but any one can go inactive to terminate the Write. The Data Input Setup and Hold timing are referenced to the rising or falling edge of the signal that terminates the Write.
2. I/O will assume the High-Z state if $\overline{OE} = V_{IH}$.

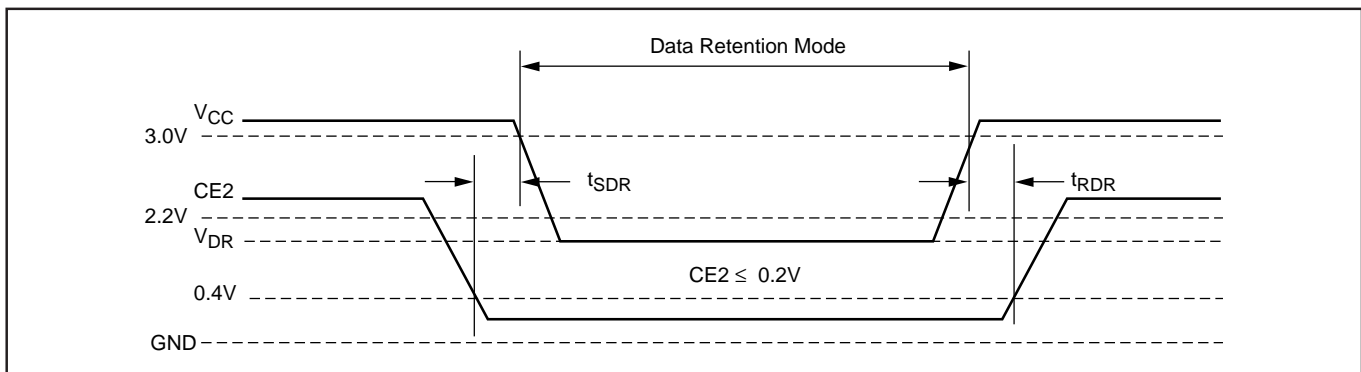
DATA RETENTION SWITCHING CHARACTERISTICS

Symbol	Parameter	TestCondition	Min.	Max.	Unit
V_{DR}	Vcc for Data Retention	See Data Retention Waveform	2.0	3.3	V
I_{DR}	Data Retention Current	$V_{CC} = 2.0V, \overline{CE1} \geq V_{CC} - 0.2V$			
		Com. (-L)	—	30	μA
		Com. (-LL)	—	5	μA
		Ind. (-L)	—	50	μA
		Ind. (-LL)	—	10	μA
t_{SDR}	Data Retention Setup Time	See Data Retention Waveform	0	—	ns
t_{RDR}	Recovery Time	See Data Retention Waveform	t_{RC}	—	ns

DATA RETENTION WAVEFORM ($\overline{CE1}$ Controlled)



DATA RETENTION WAVEFORM (CE2 Controlled)



IC62LV1024AL

ORDERING INFORMATION

Commercial Range: 0°C to +70°C

Speed (ns)	Order Part No.	Package
45	IC62LV1024AL-45Q	450milSOP
	IC62LV1024AL-45T	8*20mmTSOP-1
	IC62LV1024AL-45H	8*13.4mmTSOP-1
	IC62LV1024AL-45B	6*8mmTF-BGA
55	IC62LV1024AL-55Q	450milSOP
	IC62LV1024AL-55T	8*20mmTSOP-1
	IC62LV1024AL-55H	8*13.4mmTSOP-1
	IC62LV1024AL-55B	6*8mmTF-BGA
70	IC62LV1024AL-70Q	450milSOP
	IC62LV1024AL-70T	8*20mmTSOP-1
	IC62LV1024AL-70H	8*13.4mmTSOP-1
	IC62LV1024AL-70B	6*8mmTF-BGA

IC62LV1024AL

ORDERING INFORMATION

Industrial Range: -40°C to +85°C

Speed (ns)	Order Part No.	Package
45	IC62LV1024AL-45QI	450milSOP
	IC62LV1024AL-45TI	8*20mmTSOP-1
	IC62LV1024AL-45HI	8*13.4mmTSOP-1
	IC62LV1024AL-45BI	6*8mmTF-BGA
55	IC62LV1024AL-55QI	450milSOP
	IC62LV1024AL-55TI	8*20mmTSOP-1
	IC62LV1024AL-55HI	8*13.4mmTSOP-1
	IC62LV1024AL-55BI	6*8mmTF-BGA
70	IC62LV1024AL-70QI	450milSOP
	IC62LV1024AL-70TI	8*20mmTSOP-1
	IC62LV1024AL-70HI	8*13.4mmTSOP-1
	IC62LV1024AL-70BI	6*8mmTF-BGA

IC62LV1024ALL

ORDERING INFORMATION

Commercial Range: 0°C to +70°C

Speed (ns)	Order Part No.	Package
45	IC62LV1024ALL-45Q	450mil SOP
	IC62LV1024ALL-45T	8*20mmT SOP-1
	IC62LV1024ALL-45H	8*13.4mmT SOP-1
	IC62LV1024ALL-45B	6*8mmTF-BGA
55	IC62LV1024ALL-55Q	450mil SOP
	IC62LV1024ALL-55T	8*20mmT SOP-1
	IC62LV1024ALL-55H	8*13.4mmT SOP-1
	IC62LV1024ALL-55B	6*8mmTF-BGA
70	IC62LV1024ALL-70Q	450mil SOP
	IC62LV1024ALL-70T	8*20mmT SOP-1
	IC62LV1024ALL-70H	8*13.4mmT SOP-1
	IC62LV1024ALL-70B	6*8mmTF-BGA

IC62LV1024ALL

ORDERING INFORMATION

Industrial Range: -40°C to +85°C

Speed (ns)	Order Part No.	Package
45	IC62LV1024ALL-45QI	450mil SOP
	IC62LV1024ALL-45TI	8*20mmT SOP-1
	IC62LV1024ALL-45HI	8*13.4mmT SOP-1
	IC62LV1024ALL-45BI	6*8mmTF-BGA
55	IC62LV1024ALL-55QI	450mil SOP
	IC62LV1024ALL-55TI	8*20mmT SOP-1
	IC62LV1024ALL-55HI	8*13.4mmT SOP-1
	IC62LV1024ALL-55BI	6*8mmTF-BGA
70	IC62LV1024ALL-70QI	450mil SOP
	IC62LV1024ALL-70TI	8*20mmT SOP-1
	IC62LV1024ALL-70HI	8*13.4mmT SOP-1
	IC62LV1024ALL-70BI	6*8mmTF-BGA



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